	Туре	L	#	Hits	Search Text	DBs	Time Stamp
1	BRS	L1		1116	438/464.ccls.	16: D/ 1 •	2004/12/2 9 05:18
2	BRS	L2		11437 2	(dielectric near25 substrate)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 05:18
3	BRS	L3		I	(dielectric near25 substrate) near25 (opening or hole or recess or aperture or via)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 05:19

	Туре	L	#	Hits	Search Text	DBs	Time Stamp
4	BRS	L4			(dielectric near15 substrate) near15 (opening or hole or recess or aperture or via)	IP. D() •	2004/12/2 9 05:19
5	BRS	L5		623	(dielectric near15 substrate) near15 (opening or hole or recess or aperture or via) near15 (barrier)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 05:34
6	BRS	L6			(dielectric near15 substrate) near15 (opening or hole or recess or aperture or via) near15 (barrier) near15 (seed)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 05:42

	Туре	L	# Hits	Search Text	DBs	Time Stamp
7	BRS	L7	5	(oxide\$1 near15 substrate) near15 (opening or hole or recess or aperture or via) near15 (barrier) near15 (seed)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 05:41
8	BRS	L8	7	(dielectric) near15 (oxide) near15 (opening or hole or recess or aperture or via) near15 (barrier) near15 (seed)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 05:46
9	BRS	L9	49	(oxide) near15 (opening or hole or recess or aperture or via) near15 (barrier) near15 (seed)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 05:46

	Туре	L #	Hits	Search Text	DBs	Time Stamp
10	BRS	L10	7	(metal near oxide) near15 (opening or hole or recess or aperture or via) near15 (barrier) near15 (seed)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 05:55
11	BRS	L11	273	(oxide) near15 (opening or hole or recess or aperture or via) near15 (seed)	US- PGPUB; USPAT; EPO; DERWE NT; IBM_T DB	2004/12/2 9 05:55
12	BRS	L12		(oxide) near15 (opening or hole or recess or aperture or via) near15 (seed) near15 (barrier)	US- PGPUB ; USPAT	2004/12/2 9 06:04

	Туре	L #	Hits	Search Text	DBs	Time Stamp
13	BRS	L13	22163	(oxide) near15 (barrier)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:05
14	BRS	L14	20	(second near metal near oxide) near15 (barrier)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:07
15	BRS	L15	3		US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:08

	Туре	L #	Hits	Search Text	DBs	Time Stamp
16	BRS	L17	0	(second near oxide) near15 (seed) near5 (barrier)	IH: D() •	2004/12/2 9 06:08
17	BRS	L18	0	(second near oxide) near15 (seed) near15 (barrier)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:08
18	BRS	L19	0	(second near oxide) near15 (seed) near25 (barrier)	US- PGPUB; USPAT;	2004/12/2 9 06:09

	Туре	L	#	Hits	Search Text	DBs	Time Stamp
19	BRS	L2(0	3	(second near3 oxide) near15 (seed) near25 (barrier)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:09
20	BRS	L2:	1	4	(second near oxide)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:09
21	BRS	L1	6	46	(second near oxide) near15 (seed)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:12

	Туре	L #	Hits	Search Text	DBs	Time Stamp
22	BRS	L22	3672	(oxide) near15 (seed)	IH P() •	2004/12/2 9 06:12
23	BRS	L23	211	(oxide) near15 (seed) near15 (barrier)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:12
24	BRS	L24	32	(oxide) near15 (seed) near15 (barrier) near15 (substrate)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:16

	Туре	L	Hits	Search Text	DBs	Time Stamp
25	BRS	L25	32	(oxide or o2) near15 (seed) near15 (barrier) near15 (substrate)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:16
26	BRS	L26	0	(o2) near15 (seed) near15 (barrier) near15 (substrate)	US- PGPUB; USPAT; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:16
27	BRS	L27	0	(02) near15 (seed) near15 (barrier) near15 (substrate)	US- PGPUB ; USPAT ; EPO; JPO; DERWE NT; IBM_T DB	2004/12/2 9 06:17

	Туре	L #	Hits	Search Text	DBs	Time Stamp
28	BRS	L29	4 8	(metal near oxide) near15 (seed) near15 (substrate)	IH: P() •	2004/12/2 9 06:17
29	BRS	L28	569	(oxide) near15 (seed) near15 (substrate)	US- PGPUB; USPAT; EPO; DERWE NT; IBM_T DB	2004/12/2 9 06 : 18

	U	1	Document ID	Title	Current OR
1				Sidewall magnet improving uniformity of inductively coupled plasma and shields used therewith	204/298.06
2			US 20020088117 A1	Chromium adhesion layer for copper vias in low-k technology	29/852
3		Į.	US 6734559 B1	Self-aligned semiconductor interconnect barrier and manufacturing method therefor	257/751
4		l	US 6649513 B1	Copper back-end-of-line by electropolish	438/626
5			US 6539625 B2	Chromium adhesion layer for copper vias in low-k technology	29/846
6			US 6383929 B1	Copper vias in low-k technology	438/687
7	X		KR 2003002896 A	Method for manufacturing capacitor	